SPECIFICATIONS

Customer	
Product Name	Wire Wound SMD Power Inductor
Sunlord Part Number	SWPA5040S Series
Customer Part Number	

[Xew Released, Revised]

SPEC No.: SWPA120000

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
01		New released	/	Qintian Hou

[This SPEC is total 10 pages.] [ROHS Compliant Parts]

Approved By	Checked By	Issued By

Shenzhen Sunlord Electronics Co., Ltd.

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[For Customer Qualification Sta		Dnly】 Full [Restricted	Date:	-	
Approve			Checked By	1		
Comments:						

5040

1 Scope

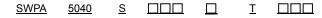
This specification applies to the SWPA5040S Series of wire wound SMD power inductor.

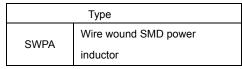
2 Product Description and Identification (Part Number)

1) Description:

SWPA5040S series of Wire wound SMD power inductor.

2) Product Identification (Part Number)





Feature type			
s	Standard Type		

Inductance Tolerance			
N ±30%			
М	±20%		

Tape Carrier Package

Packing

Example	Example
1R0	1.0uH
100	10uH
101	100uH

Nominal Inductance

External Dimensions(L×W×H) [mm]

5.0X5.0X 4.0

- .

Special Process code					
	Special Process code				
* Standard product is blank					

3 Electrical Characteristics

Т

Please refer to Item 12.

- 1) Operating and storage temperature range (individual chip without packing): -40 ~ +125 (Including Self-heating)
- 2) Storage temperature range (packaging conditions): -10 ~+40 and RH 70% (Max.)

4 Test and Measurement Procedures

4.1 Test Conditions

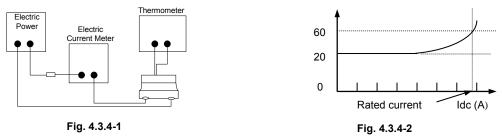
- 4.1.1 Unless otherwise specified, the standard atmospheric conditions for measurement/test as:
 - a. Ambient Temperature: 20±15
 - b. Relative Humidity: 65±20%
 - c. Air Pressure: 86kPa to 106kPa
- 4.1.2 If any doubt on the results, measurements/tests should be made within the following limits:
 - a. Ambient Temperature: 20±2
 - b. Relative Humidity: 65±5%
 - c. Air Pressure: 86kPa to 106kPa

4.2 Visual Examination

Inspection Equipment: Visual.

4.3 Electrical Test

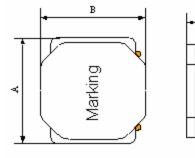
- 4.3.1 Inductance (L)
 - a. Refer to Item 12. Test equipment: WK3260B LCR meter or equivalent.
 - b. Test Frequency and Voltage: refers to Item 12.
- 4.3.2 Direct Current Resistance (DCR)
 - a. Refer to Item 12.
 - b. Test equipment: HIOKI 3540 or equivalent.
- 4.3.3 Saturation Current (Isat)
 - a. Refer to Item 12.
 - b. Test equipment: WK3260B LCR meter or equivalent.
 - c. Definition of saturation current (Isat): DC current at which the inductance drops approximate 30% from its value without current.
- 4.3.4 Temperature rise current (Irms)
 - a. Refer to Item 12.
 - b. Test equipment (see Fig. 4.3.4-1, Fig. 4.3.4-2): Electric Power, Electric current meter, Thermometer.
 - c. Measurement method
 - 1. Set test current to be 0 mA.
 - 2. Measure initial temperature of choke surface.
 - 3. Gradually increase current and measure choke temperature for corresponding current.
 - 4. Definition of Temperature rise current: DC current that causes the temperature rise (T =40°C) from 20°C ambient

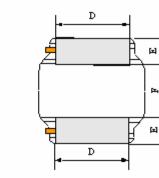


5 Shape and Dimensions

Dimensions and recommended PCB pattern for reflow soldering, please see Fig.5-1, Fig. 5-2 and Table 5-1.

С





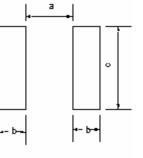
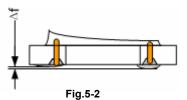


Fig.5-1

Series	А	В	C.	D	E	F	a.	b.	С.
SWPA5040S	5.0±0.2	5.0±0.2	4.0 Max	4.0±0.2	1.25±0.2	2.5±0.2	2.3 Тур	1.4 Тур	4.2 Тур



 Δf : Clearance between terminal and the surface of plate must be 0.2mm max when coil is placed on a flat plate.

6 Structure

The structure of SWPA5040S product, please refer to Fig.6-1 and Table 6-1.

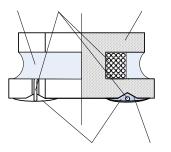
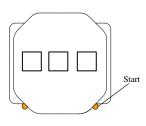


Fig. 6-1

7 Product Marking

Please refer to Fig. 7-1.

The content of marking please refers to Item 12.



[Table 6-1]

No.	Components	Material
	Ferrite Core	Ni-Zn Ferrite
	Wire	Polyurethane system enameled copper wire
	Magnetic Glue	Epoxy resin and magnetic powder
	Plating Electrodes	Plating: Ag/Ni/Sn
	Outer Electrodes	Top surface solder coating:Sn96.5%/Ag3.0%/Cu0.5%

8 Reliability	7 Test	
Items	Requirements	Test Methods and Remarks
8.1 Terminal Strength	No removal or split of the termination or other defects shall occur.	Solder the inductor to the testing jig (glass epoxy board shown in Fig.8.1-1) using eutectic solder. Then apply a force in the direction of the arrow. 10N force. Keep time: 5s
8.2 Resistance to Flexure	Fig.8.1-1 No visible mechanical damage.	Solder the chip to the test jig (glass epoxy board) using eutectic solder. Then apply a force in the direction shown as Fig.8.2-1 . Flexure: 2mm Pressurizing Speed: 0.5mm/sec Keep time: 30±1s Test board size: 100X40X1.0 Land dimension: Please see Fig. 5-1
8.3 Vibration	Fig.8.2-1 No visible mechanical damage. Inductance change: Within ±10%	Solder the chip to the testing jig (glass epoxy board shown as the following figure) using eutectic solder. The chip shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours).
8.4 Temperature coefficient	Inductance change: Within ±20%	Temperature: -40 ~+125 With a reference value of +20 , change rate shall be calculated
8.5 Solderability	90% or more of electrode area shall be coated by new solder.	The test samples shall be dipped in flux, and then immersed in molten solder. Solder temperature: 245±5 Duration: 5±1 sec. Solder: Sn/3.0Ag/0.5Cu Flux: 25% resin and 75% ethanol in weight Immersion depth: all sides of mounting terminal shall be immersed
8.6 Resistance to Soldering Heat	No visible mechanical damage. Inductance change: Within ±10%	Re-flowing Profile: Please refer to Fig. 8.6-1 . Test board thickness: 1.0mm Test board material: glass epoxy resin The chip shall be stabilized at normal condition for 1~2 hours before measuring 260 260 Max Ramp Up Rate=3 /sec. Max Ramp Down Rate=6 /sec 60 90sec. 25 Time 25 to Peak =8 min max Fig. 8.6-1

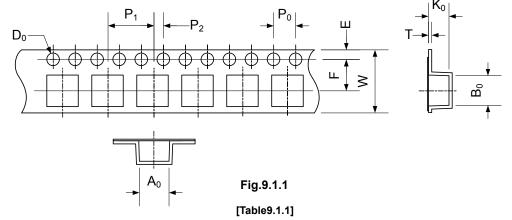
8.7 Thermal Shock	No visible mechanical damage. Inductance change: Within ±10% 125 30 min. 30 min. Ambient	Temperature and time: -40±3 for 30±3 min→125 for 30±3min, please refer to Fig. 8.7-1 . Transforming interval: Max. 20 sec Tested cycle: 100 cycles The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.8 Resistance to Low Temperature	No visible mechanical damage Inductance change: Within ±10%	Temperature: -40±3 Duration: 1000 ^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.9 Resistance to High Temperature	No mechanical damage. Inductance change: Within ±10%	Temperature: 125±2 Duration: 1000 ^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring.
8.10 Damp Heat	No mechanical damage. Inductance change: Within ±10%	Temperature: 60±2 Humidity: 90% to 95%RH Duration: 1000 ^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.11 Loading Under Damp Heat	No mechanical damage. Inductance change: Within ±10%	Temperature: 60±2 Humidity: 90% to 95% RH Applied current: Rated current Duration:1000 ^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.12 Loading at High Temperature	No mechanical damage. Inductance change: Within ±10%	Temperature: 85±2 Applied current: Rated current Duration: 1000 ^{±24} hours The chip shall be stabilized at normal condition for 1~2 hours before measuring

9 Packaging

9.1 Tape and Reel Packaging Dimensions

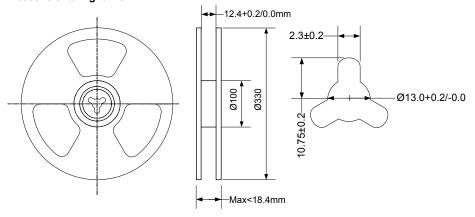
9.1.1Taping Dimensions (Unit: mm

Please refer to Fig. 9.1.1 and Table 9.1.1



Series	A ₀	B ₀	W	E	F	P ₀	P ₁	P ₂	D ₀	т	K ₀
SWPA5040S	5.3±0.1	5.3±0.1	12.0±0.3	1.75±0.1	5.5±0.1	4.0±0.1	8.0±0.1	2.0±0.1	1.5+0.1/-0.0	0.4±0.03	4.2±0.1

- Trailer 9.1.2 Direction of rolling no component Please refer to Fig. 9.1.2. 100mm min+ \bigcirc \cap \cap C) \bigcirc \bigcirc \bigcirc \bigcirc \bigcirc 7 \bigcirc Leader Trailer no componen no component 160mm min - Components 400mm min User direction of feeder Fig.9.1.2
- 9.1.3 Reel Dimensions (Unit: mm) Please refer to **Fig. 9.1.3**.



Flg.9.1.3

- 9.1.4 Top tape strength Peel-off strength: 10~130gf . Peel-off angle: 165°~180°, refers to Fig.9.1.4. Peel-off speed: 300mm/min. 9.1.5 The number of components A tape & reel package contains 1500 inductors.
- 9.1.6 The allowable number of empty chip cavities Maximum two (2) chip cavities missing product may exist in a reel but they may not be consecutive two cavities.

9.2 Packing Documents and Marking

- 9.2.1Packing Documents
 - Packing documents include the following:
 - 1) Packaging list
 - 2) Certificate of compliance (COC)
- 9.2.2Packing QTY.
 - 1) Inner Box: 1 reel in each box.
 - 2) Outer Box: 2 or 4 inner boxes in each outer case.
 - 3) 2 or 4 reels in each outer case.
- 9.2.3Marking

1)Marking label information on reels includes (see Fig.9.2.3-1~2):

- a). P/O No
- b). Customer Part No.
- c). Sunlord Part No.
- d). Quantity..
- e). Lot No.
- f). Date code
- g). Inspection stamp
- h). MFG address as 'Made In China'

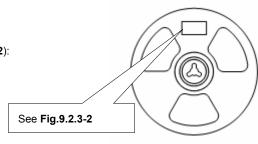


Fig.9.2.3-1

SHENZHEN SU	NLORD ELECTR	ONICS CO.,LTD.	MADE IN CHINA
Sunlord	Datecode	8: XXXX	Hazardous Substance Free
Lot NO.:	XXXX		HSF
Quantity:	XXXX	PCS	
Sunlord Part N	0.: XXXXXX	XXXXXXX	
Cust Part NO.:	XXXXXXXX	0000X	
P/O NO.		0000X	

Fig.9.2.3-2

"Shenzhen Sunlord Electronics Co., Ltd."

Example; "1/10" means that this case is the 1st one

Packing label include the following:

Customer Part No.

Sunlord Part No.

Inspection Stamp.

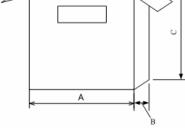


Fig.9.2.3-3

2)Marking label information on inner box

- Inner box please refers to Fig.9.2.3-3 and Table 9.2.3-1. a).
- b). Marking Label on inner box N/A.

a).

b).

i)

ii)

iii)

iv)

V) vi)

vii)

viii)

ix)

3)Marking on outer case (see Fig.9.2.3-4~6): Out case size pleases reefers to Table 9.2.3-2.

Manufacturer: Sunlord ID:

Customer

Date code

C/No.

P/O No.

Quantity.

Of total 10 cases

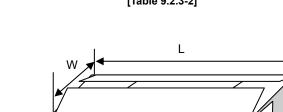
Manufacturer

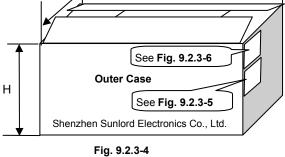
Packaging type	A(mm)	B(mm)	C(mm)
Inner box	340	30	340

[Table 9.2.3-1]

Packaging type	L(mm)	W(mm)	H(mm)
TYP1	380	380	250
TYP2	380	380	190

[Table 9.2.3-2]





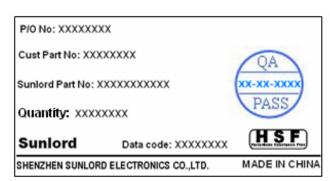


Fig.9.2.3-5

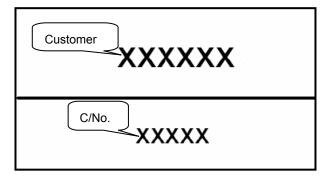


Fig.9.2.3-6

File No:		andard of product Applied to	REV:01	
Effective	e date:		REV.VI	
No.	Defect Item	Graphic	Rejection identification	Acceptance
1	Core defect		The defect length/width (I or <i>w</i>) more than L/6 or W/6, NG.	AQL=0.65
2	Core crack		Visual cracks, NG.	AQL=0.65
3	Starvation		Resin starved length, <i>I</i> , more than L/2, NG. IF <i>W</i> 2mm, resin starved width, <i>w</i> , more than W/2, NG. IF <i>W</i> 2mm, resin starved width, <i>w</i> , don't control.	AQL=0.65
4	Excessive glue		The length, width or height of product beyond specified value, NG.	AQL=0.65
5	Cold solder		For SWPA252012S, cold solders / more than 0.5 mm, NG. For other series, cold solders / more than 1 mm, NG.	AQL=0.65
6	Solder icicle		The height H of product beyond specified value, NG; The clearance Δf beyond specified value listed in Item 5 , NG;	AQL=0.65
7	Electrode uneven	h	The clearance Δf beyond specified value listed in Item 5 , NG;	AQL=0.65
8	Marking defect		The content of marking 1) is indistinct, 2) disagrees with current product P/N requirements, NG; Intersection angle by L1 and L2 more than 45°, NG.	AQL=0.65

10 Visual inspection standard of product

11 Recommended Soldering Technologies

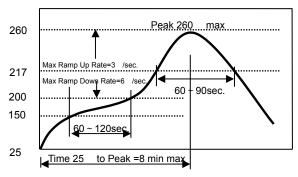
11.1Re-flowing Profile:

Preheat condition: 150 ~200 /60~120sec. Allowed time above 217 : 60~90sec. Max temp: 260 Max time at max temp: 5sec. Solder paste: Sn/3.0Ag/0.5Cu Allowed Reflow time: 2x max Please refer to **Fig. 11.1-1**.

[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]

11.2 Iron Soldering Profile:

Iron soldering power: Max. 30W Pre-heating: 150 /60sec. Soldering Tip temperature: 350 Max. Soldering time: 3sec. Max. Solder paste: Sn/3.0Ag/0.5Cu Max.1 times for iron soldering Please refer to **Fig. 11.2-1**. [Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]





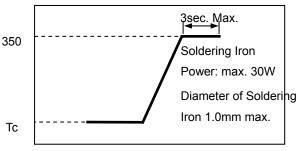
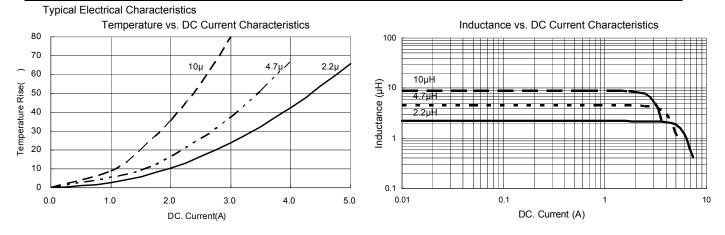


Fig. 11.2-1

12 Electrical Characteristics

Customer	Part Number	Inductance	L Tolerance	Inductance Test Condition	DC Resistance (±30%)	Saturation Current	Temperature Rise Current	Min. Self- resonant frequency	Marking
P/N	Units	μH	-	-	Ω	А	А	MHz	-
	Symbol	L	-	-	DCR	lsat	Irms	SRF	-
	SWPA5040S1R0NT	1.0	±30%	100KHz,1V	0.012	7.35	4.90	117	1R0
	SWPA5040S1R2NT	1.2	±30%	100KHz,1V	0.016	6.50	4.15	110	1R2
	SWPA5040S1R5NT	1.5	±30%	100KHz,1V	0.015	6.30	4.30	86	1R5
	SWPA5040S2R2NT	2.2	±30%	100KHz,1V	0.019	4.90	3.80	50	2R2
	SWPA5040S2R7NT	2.7	±30%	100KHz,1V	0.022	4.30	3.60	37	2R7
	SWPA5040S3R3NT	3.3	±30%	100KHz,1V	0.024	3.95	3.40	32	3R3
	SWPA5040S3R9NT	3.9	±30%	100KHz,1V	0.027	3.55	3.20	29	3R9
	SWPA5040S4R7NT	4.7	±30%	100KHz,1V	0.030	3.50	3.00	28	4R7
	SWPA5040S6R8MT	6.8	±20%	100KHz,1V	0.043	2.90	2.50	21	6R8
	SWPA5040S100MT	10	±20%	100KHz,1V	0.064	2.35	2.10	18	100
	SWPA5040S150MT	15	±20%	100KHz,1V	0.086	2.00	2.00	13	150
	SWPA5040S220MT	22	±20%	100KHz,1V	0.129	1.60	1.50	11	220
	SWPA5040S330MT	33	±20%	100KHz,1V	0.188	1.30	1.20	9	330
	SWPA5040S470MT	47	±20%	100KHz,1V	0.272	1.10	1.00	7	470
	SWPA5040S680MT	68	±20%	100KHz,1V	0.400	0.90	0.80	6	680
	SWPA5040S101MT	100	±20%	100KHz,1V	0.560	0.75	0.70	5	101

Specifications for Wire Wound SMD Power Inductor



13 Precautions

13.1 Surface mounting

- Mounting and soldering condition should be checked beforehand.
- Applicable soldering process to this product is reflow soldering only.
- Recommended conditions for repair by soldering iron:
 - Preheat the circuit board with product to repair at 150 for about 1 minute.
 - Put soldering iron on the land-pattern.
 - Soldering iron's temperature: 350 maximum/Duration: 3 seconds maximum/1 time for each terminal.
 - The soldering iron should not directly touch the inductor.

Product once removes from the circuit board may not be used again.

13.2 Handing

- Keep the products away from all magnets and magnetic objects.
- Be careful not to subject the products to excessive mechanical shocks.
- Please avoid applying impact to the products after mounted on pc board.
- Avoid ultrasonic cleaning.

13.3 Storage

- To maintain the solderability of terminal electrodes and to keep the packing material in good condition, temperature and humidity in the storage area should be controlled.
- Recommended conditions: -10 ~40 , 70%RH (Max.)
- Even under ideal storage conditions, solderability of products electrodes may decrease as time passes. For this reason, product should be used with one year from the time of delivery.
- In case of storage over 6 months, solderability shall be checked before actual usage.

13.4 Regarding Regulations

- Any Class- or Class- ozone-depleting substance (ODS) listed in the Clean Air Act in US for regulation is not included in the products or applied to the products at any stage of whose manufacturing processes.
- Certain brominated flame retardants (PBBs,PBDEs) are not used at all.
- The products of this specification are not subject to the Export Trade Control Order in China or the Export Administration Regulations in US.

13.5 Guarantee

• The guaranteed operating conditions of the products are in accordance with the conditions specified in this specification.

• Please note that Sunlord takes no responsibility for any failure and/or abnormality which is caused by use under other than the aforesaid operating conditions.

14 Supplier Information

14.1 Supplier:

Shenzhen Sunlord Electronics Co., Ltd.

14.2 Manufacturer:

Shenzhen Sunlord Electronics Co., Ltd.

14.3 Manufacturing Address:

Sunlord Industrial Park, Dafuyuan Industrial Zone, Guanlan, Shenzhen, China Zip: 518110